

SiC MOS P3M07008PQ

N-Channel Enhancement Mode

Features

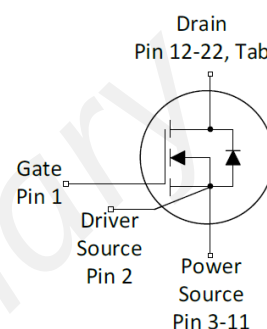
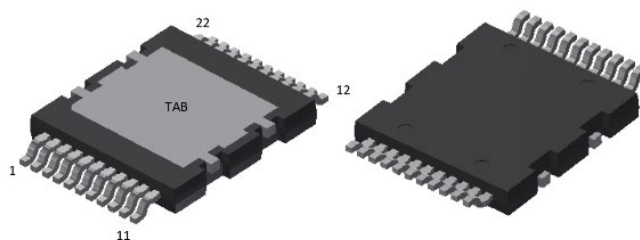
- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small Q_{gd}
- 100% UIS tested

Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost

Applications

- Solar Inverters
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies



PQPAK-LF-22

Gate	1
Kelvin Source	2
Power Source	3-11
Drain	TAB (12-22)



Order Information

Part Number	Package	Marking
P3M07008PQ	PQPAK-LF-22	P3M07008PQ



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1. Maximum Ratings

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	V_{DSmax}	750	V	$V_{GS} = 0V$ $I_D = 100\mu A$
Gate - Source Voltage (dynamic)	V_{GSmax}	-8 / +22	V	AC ($f > 1\text{ Hz}$)
		-10 / +25		$t_p \leq 20ns$, duty cycle $\leq 1\%$
Gate - Source Voltage(static) turn-on gate voltage turn-off gate voltage	$V_{GS,on}$ $V_{GS,off}$	+15 / +18 -3	V	Static
Continuous Drain Current	I_D	208	A	$V_{GS} = 18V$ $T_C = 25^\circ\text{C}$
		147		$V_{GS} = 18V$ $T_C = 100^\circ\text{C}$
Pulsed Drain Current	$I_{D(pulse)}$	700	A	$PW \leq 10\mu s$, Duty cycle $\leq 1\%$
Power Dissipation	P_D	789	W	
Operating Junction	T_J	-55 To +150	$^\circ\text{C}$	
Storage Temperature	T_{stg}	-55 To +175	$^\circ\text{C}$	
Solder Temperature	T_L	245	$^\circ\text{C}$	

2. Electrical Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	750	/	/	V	$V_{GS} = 0V$ $I_D = 2.5mA$
Gate Threshold Voltage	$V_{GS(th)}$	2.0	2.7	/	V	(tested after 30ms pulse at $V_{GS} = 18V$) $V_{DS} = V_{GS}$ $I_D = 20mA$ $T_J = 25^\circ\text{C}$
		/	1.9	/	V	$V_{DS} = V_{GS}$ $I_D = 20mA$ $T_J = 175^\circ\text{C}$
Reverse Bias Drain Current	I_{DSS}	/	5	250	μA	$V_{GS} = 0V$ $V_{DS} = 750V$
Gate-Source Leakage Current	I_{GSS}	/	5	250	nA	$V_{GS} = 18V$ $V_{DS} = 0V$
Drain-Source On-State Resistance	$R_{DS(on)}$	/	8	12	m Ω	$V_{GS} = 18V$ $I_D = 75A$ $T_J = 25^\circ\text{C}$
		/	11	/		$V_{GS} = 18V$ $I_D = 75A$ $T_J = 175^\circ\text{C}$
Trans conductance	g_{fs}	/	48	/	S	$V_{DS} = 20V$ $I_{DS} = 75A$ $T_J = 25^\circ\text{C}$
		/	45	/		$V_{DS} = 20V$ $I_{DS} = 75A$ $T_J = 175^\circ\text{C}$



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Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Input Capacitance	C_{iss}	/	7698	/	pF	$V_{GS} = 0V$ $V_{DS} = 500V$ $f = 500kHz$ $V_{AC} = 25mV$
Output Capacitance	C_{oss}	/	516	/		
Reverse Transfer Capacitance	C_{rss}	/	40	/		
Coss Stored Energy	E_{oss}	/	112	/	μ	
Turn-on Energy	E_{on}	/	664	/	μ	$V_{DS} = 500V$ $V_{GS} = -3/18V$ $I_D = 75A$ $R_G = 1\Omega$
Turn-off Energy	E_{off}	/	194	/		
Turn-On Delay Time	$t_{d(on)}$	/	24.8	/		$V_{DS} = 500V$ $V_{GS} = -3/18V$ $I_D = 75A$ $R_G = 1\Omega$
Rise Time	t_r	/	39	/		
Turn-Off Delay Time	$t_{d(off)}$	/	82	/		
Fall Time	t_f	/	8.6	/		
Internal Gate Resistance	$R_{G(int)}$	/	1.5	/	Ω	$f = 1MHz$ $V_{AC} = 25mV$
Gate to Source Charge	Q_{gs}	/	245	/	nC	$V_{DS} = 500V$ $I_{DS} = 75A$ $V_{GS} = -3/18V$ $I_G = 20mA$
Gate to Drain Charge	Q_{gd}	/	85	/		
Total Gate Charge	Q_g	/	407	/		

3. Reverse Diode Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	V_{SD}	5.2	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 38\text{A}$ $T_J = 25^\circ\text{C}$
		4.6	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 38\text{A}$ $T_J = 175^\circ\text{C}$
Continuous Diode Forward Current	I_S	68	/	A	$V_{GS} = -3\text{V}$
Reverse Recover Time	t_{rr}	21	/	ns	$V_{GS} = -3/18\text{V}$ $I_{SD} = 75\text{A}$
Reverse Recovery Charge	Q_{rr}	926	/	nC	$V_R = 500\text{V}$ $dI/dt = 4200\text{A}/\mu\text{s}$
Peak Reverse Recovery Current	I_{rrm}	74	/	A	$T_J = 25^\circ\text{C}$

4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.19	$^\circ\text{C}/\text{W}$

5. Typical Performance

At $T_J = 25^\circ\text{C}$, unless specified otherwise

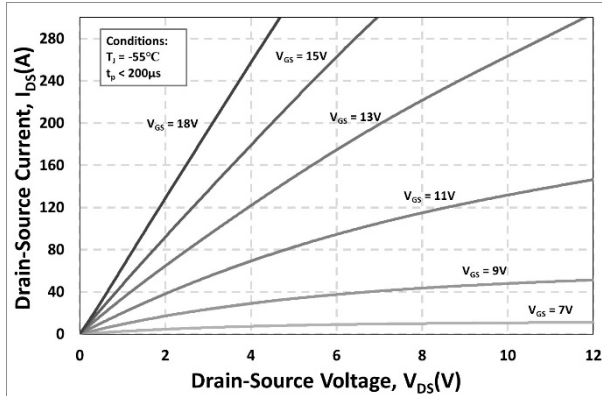


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

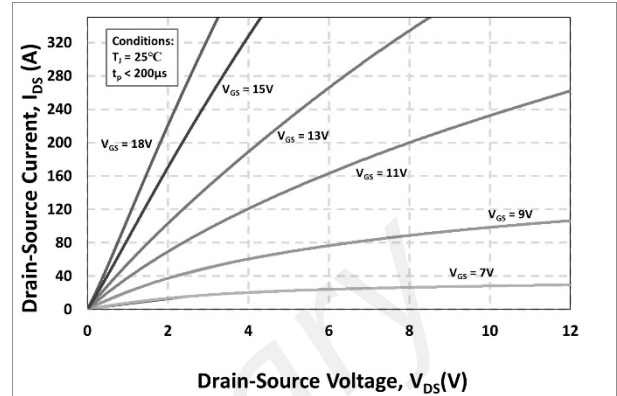


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

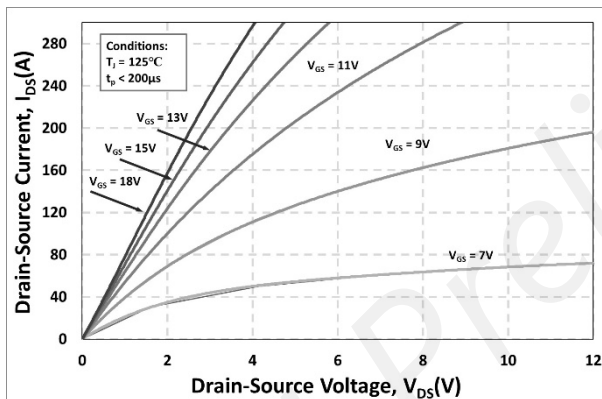


Figure 3. Output Characteristics $T_J = 125^\circ\text{C}$

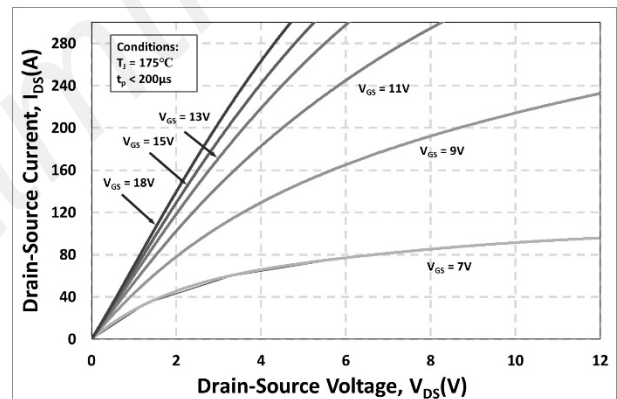


Figure 4. Output Characteristics $T_J = 175^\circ\text{C}$

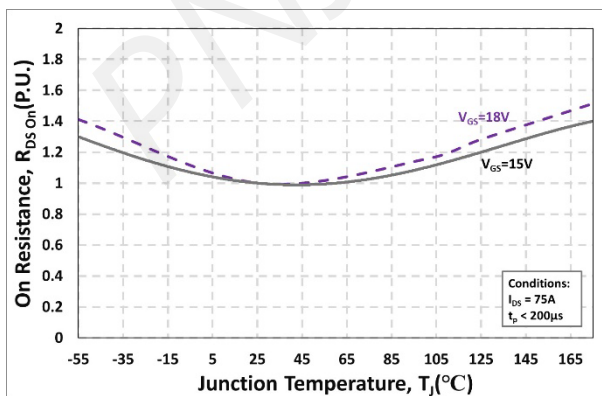


Figure 5. Normalized On-Resistance vs. Temperature

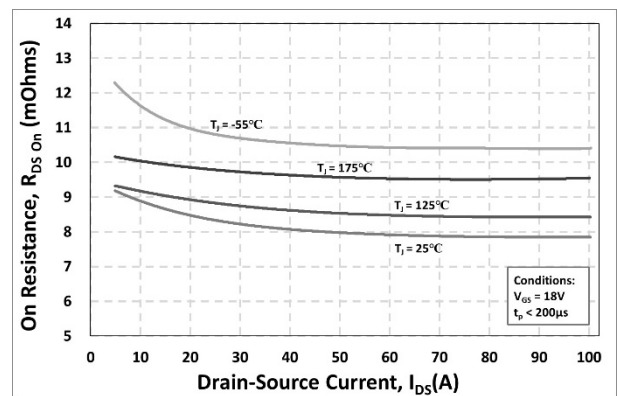


Figure 6. On-Resistance vs. Drain Current Various Temperatures

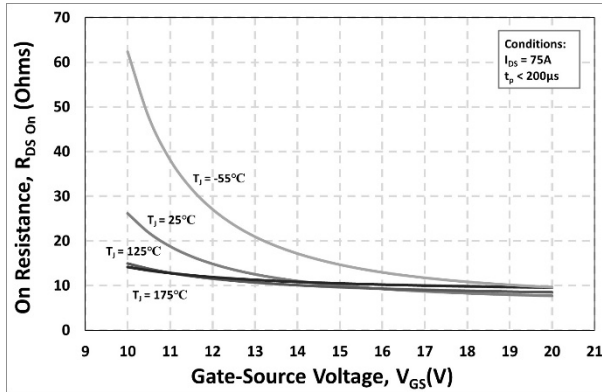


Figure 7. On-Resistance vs. Gate-Source Voltage

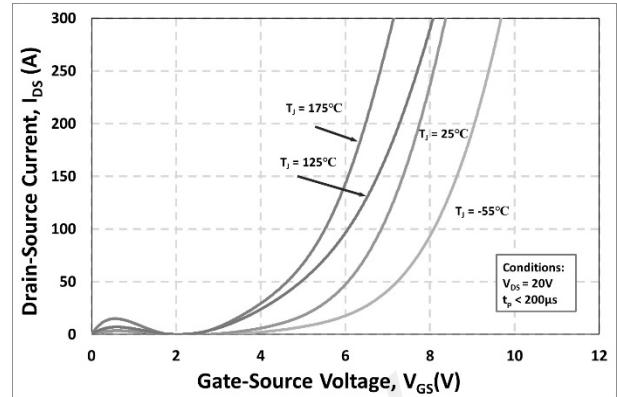


Figure 8. Transfer Characteristic for Various Junction Temperatures

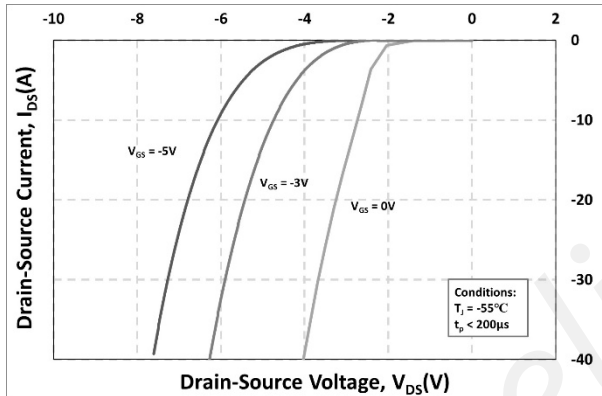


Figure 9. Body Diode Characteristic at -55°C

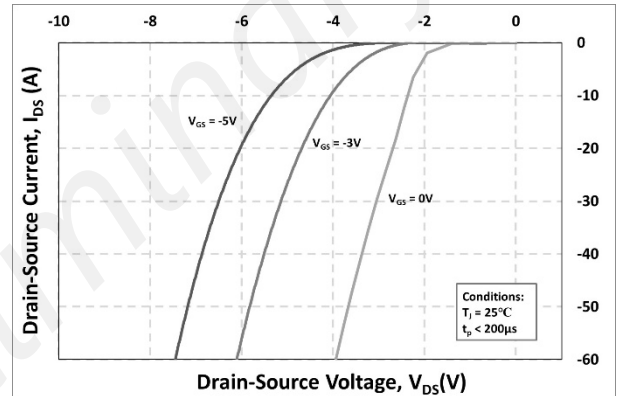


Figure 10. Body Diode Characteristic at 25°C

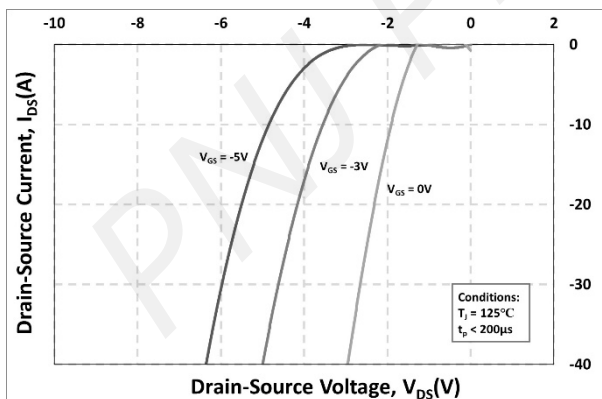


Figure 11. Body Diode Characteristic at 125°C

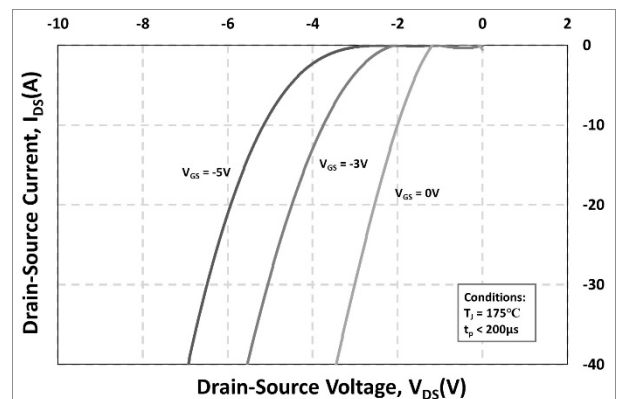


Figure 12. Body Diode Characteristic at 175°C

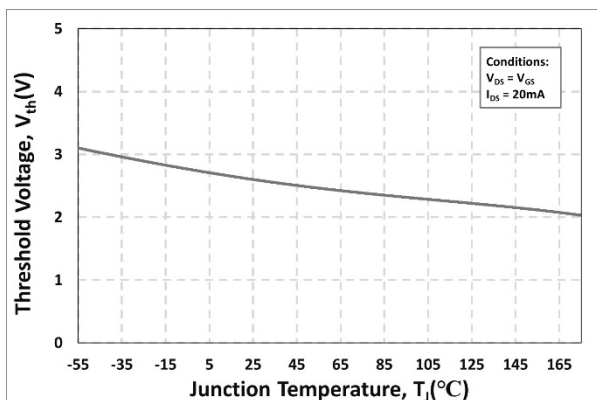


Figure 13. Threshold Voltage vs. Temperature

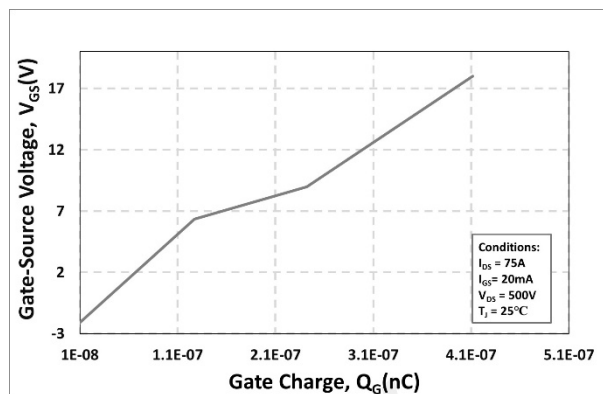


Figure 14. Gat Charge Characteristics

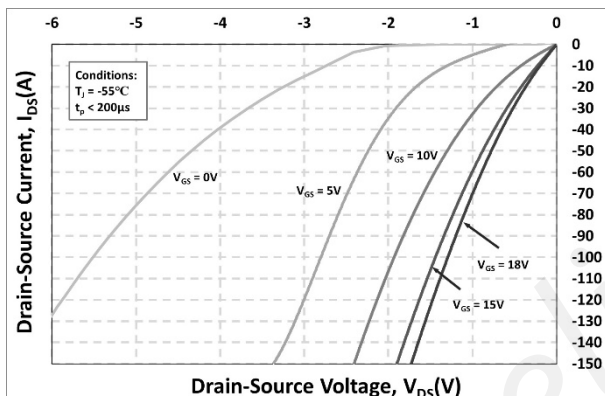


Figure 15. 3rd Quadrant Characteristic at -55°C

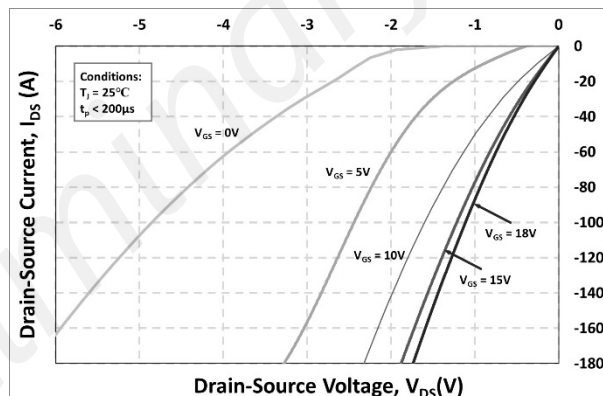


Figure 16. 3rd Quadrant Characteristic at 25°C

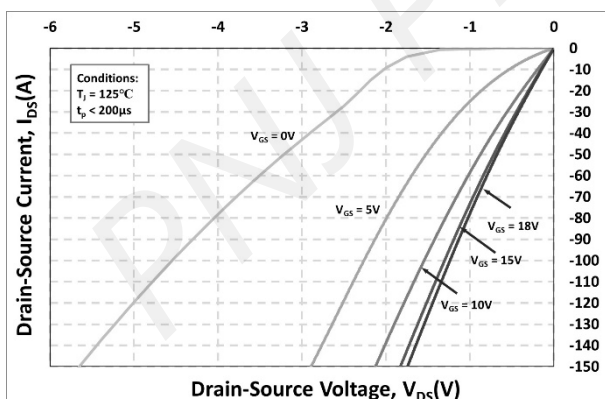


Figure 17. 3rd Quadrant Characteristic at 125°C

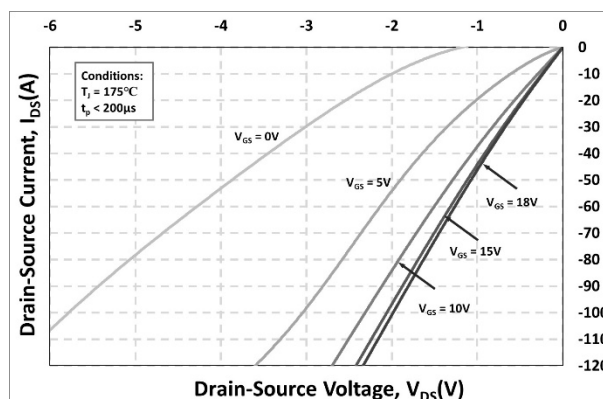


Figure 18. 3rd Quadrant Characteristic at 175°C

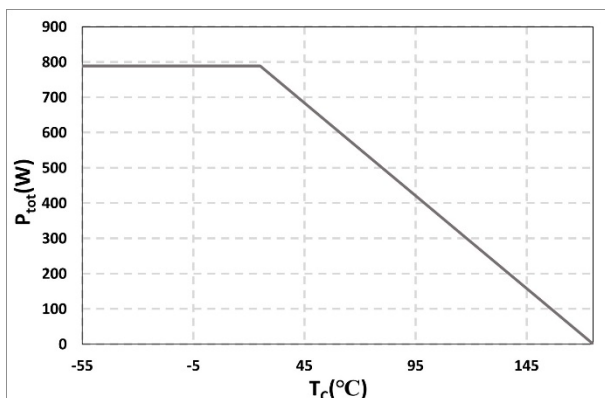


Figure 19. Maximum Power Dissipation Derating vs. Case Temperature

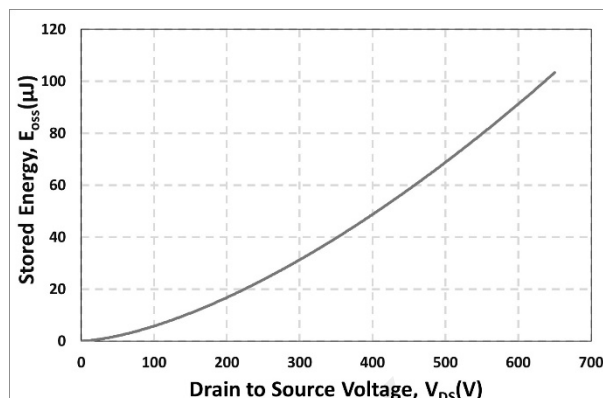


Figure 20. Output Capacitor Stored Energy

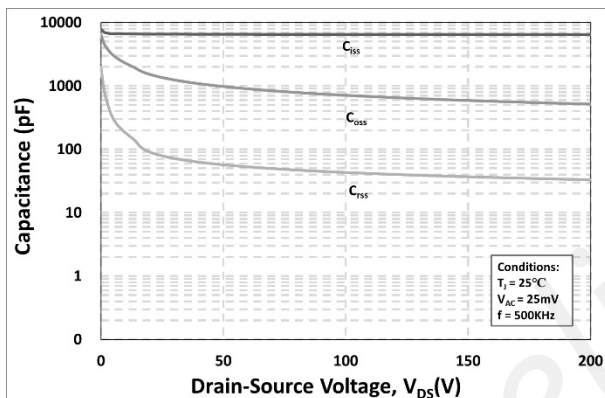


Figure 21. Capacitances vs. Drain-Source Voltage (0 - 200V)

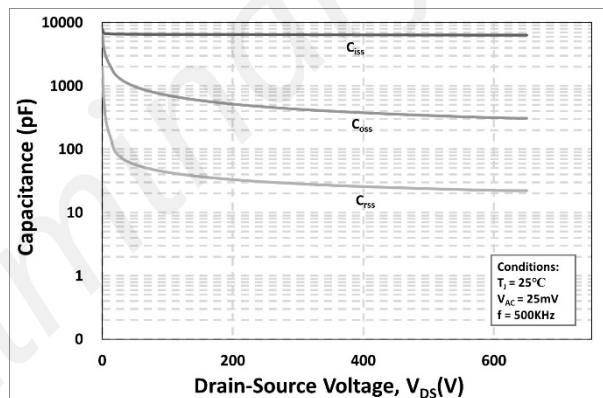
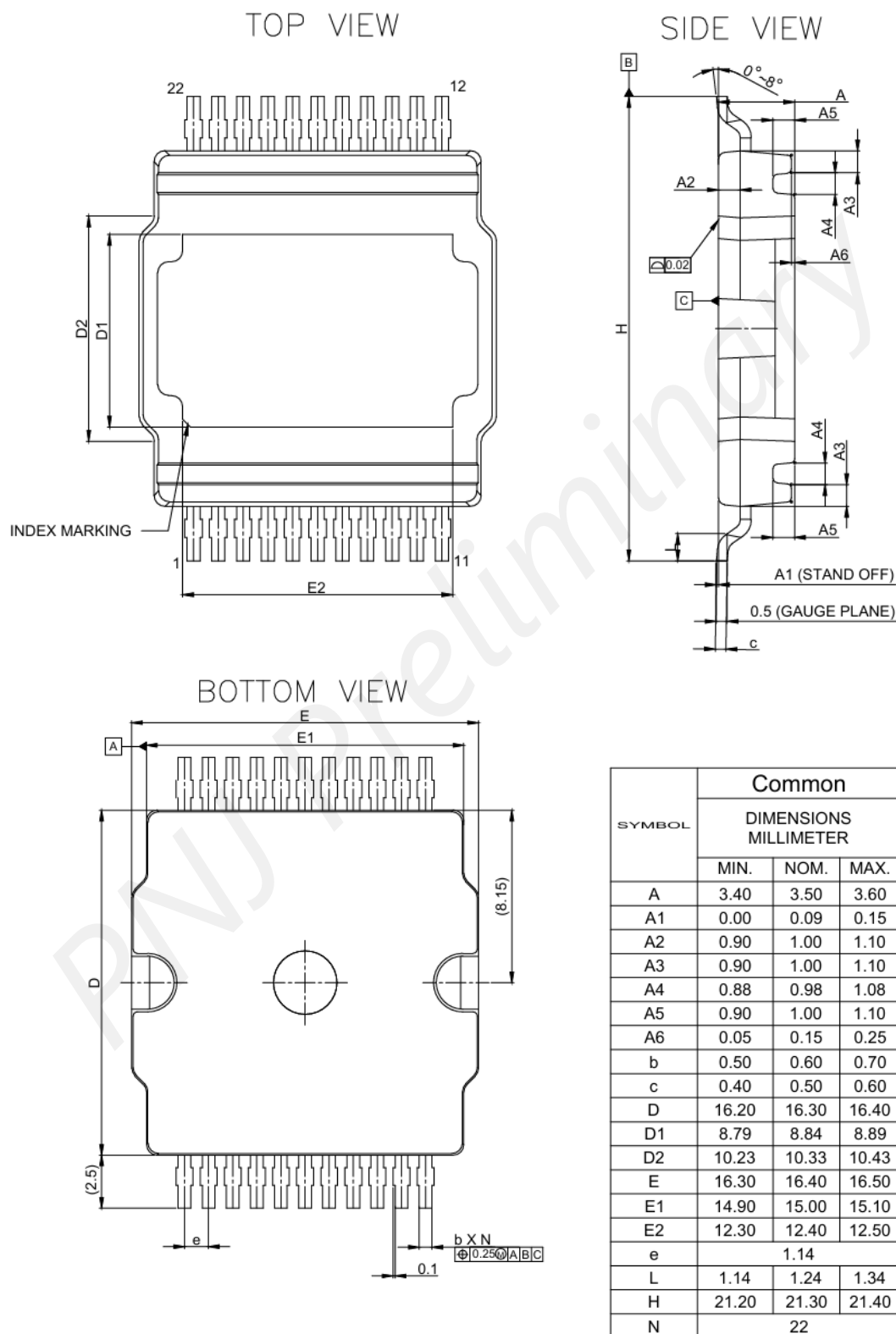


Figure 22. Capacitances vs. Drain-Source Voltage (0 - 750V)

6. Package Outlines



Drawing and Dimensions



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